

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination MASUDA ET AL.	
		Examiner Michael Bernshteyn	Art Unit 1713	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2001/0005742	06-2001	Moriyama et al.	526/317.1
	B	US-			
	C	US-			
	D	US-			
	E	US-			
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	I	US-			
	J	US-			
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	M	US-			

FOREIGN PATENT DOCUMENTS

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*	N	JP 02269709 A	11-1990	Japan	NAKAGAWA et al.	
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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